



TEST REPORT

REPORT NUMBER: I21W00031-EMC

ON

Type of Equipment: LTE Cat.1 cellular module

Type of Designation: SLM320-L

Brand Name: MEIG Link

Manufacturer: MeiG Smart Technology Co., Ltd

ACCORDING TO Subpart B, PART 15, RADIO FREQUENCY DEVICES

Chongqing Academy of Information and Communication Technology

Month date, year Sep 27, 2021

Signature

句罗勇

Xiang Luoyong

Director

Note:

The test results in this test report relate only to the devices specified in this report. This report shall not be reproduced except in full without the written approval of Chongqing Academy of Information and Communication Technology.





Revision Version

Report Number	Revision	Date	Memo		
I21W00031-EMC	00	2021-09-27	Initial creation of test report		





FCC ID: 2APJ4-SLM320-L

Report Date: 2021-09-27

Test Firm Name:

Chongqing Academy of Information and

Communication Technology

FCC Registration Number: CN1239

Statement

The measurements shown in this report were made in accordance with the procedures described on test pages. All reported tests were carried out on a sample equipment to demonstrate limited compliance with FCC CFR 47 Part 15B. The sample tested was found to comply with the requirements defined in the applied rules.





CONTENTS

1 GENERAL INFORMATION	4
1.1 Notes	4
1.2 Testers	5
1.3 TESTING LABORATORY INFORMATION	6
1.4 DETAILS OF APPLICANT OR MANUFACTURER	7
2 TEST ITEM	8
2.1 General Information	8
2.2 OUTLINE OF EUT	8
2.3 MODIFICATIONS INCORPORATED IN EUT	8
2.4 EQUIPMENT CONFIGURATION	8
2.5 OTHER INFORMATION	8
3 SUMMARY OF TEST RESULTS	9
4.TEST EQUIPMENT AND TEST SOFTWARE	9
5 TEST RESULTS	10
5.1 RADIATED EMISSION	10
5.2 CONDUCTED EMISSION	14
ANNEX A EXTERNAL PHOTOS	17
ANNEX B INTERNAL PHOTOS	17
ANNEX C DEVIATIONS FROM PRESCRIBED TEST METHODS	17





1 General Information

1.1 Notes

All reported tests were carried out on a sample equipment to demonstrate limited compliance with FCC CFR 47 Part15B.

The test results of this test report relate exclusively to the item(s) tested as specified in section 2.

The following deviation from, additions to, or exclusions from the test specifications have been made. See Annex C.

Chongqing Academy of Information and Communications authorizes the applicant or manufacturer (see section 1.4) to reproduce this report provided, and the test report may only be reproduced or published in full. Reproduction or publication of extracts from the report requires the prior written approval of Chongqing Academy of Information and Communication Technology Mr. Zhang Yan.

Any use which a third party makes of this report, or any reliance on or decisions to be made based on it, are the responsibility of such third parties. Chongqing Institute of Telecommunications accepts no responsibility for damages, if any, suffered by any third party as a result of decisions made or actions based on this report.





1.2 Testers

Name: Chen Xin

Position: Engineer

Department: Department of EMC test

Date: 2021-09-27

Signature:

陈鑫

Editor of this test report:

Name: Xiao Yu

Position: Engineer

Department: Department of EMC test

Date: 2021-09-27

Signature:

1679

Technical responsibility for area of testing:

Name: Xiang Luoyong

Position: Manager

Department: Department of EMC test

Date: 2021-09-27

Signature:





1.3 Testing Laboratory information

1.3.1 Location	
Name:	Chongqing Academy of Information and Communcations
Address:	Building B, Technology Innovation Center, No.8, Yuma
	Road, Chayuan New Area, Nan'an District, Chongqing,
	People's Republic of China, 401336
Tel:	+86 23 88069965
Fax:	+86 23 88608777
Email:	liqiao@caict.ac.en
1.3.2 Details of accreditation s	tatus
Accredited by:	
Registration number:	
Standard:	
1.3.3 Test location, where diffe	erent from section 1.3.1
Name:	
Address:	





1.4 Details of applicant or manufacturer

1.4.1 Applicant

Name: MeiG Smart Technology Co., Ltd

Address: 3/F, No.88, Qinjiang Road, Xuhui District, Shanghai

Country: CHINA

Telephone: 021-54278676

Fax:

Contact: louxinwei

Email: louxinwei@meigsmart.com

1.4.2 Manufacturer (if different from applicant in section 1.4.1)

Name: MeiG Smart Technology Co., Ltd

Address: 3/F, No.88, Qinjiang Road, Xuhui District, Shanghai

Country: CHINA





2 Test Item

2.1 General Information

Manufacturer: MeiG Smart Technology Co., Ltd

Name: LTE Cat.1 cellular module

Model Number: SLM320-L

Serial Number: M320L16AHB071800060

IMEI: 863069057875412
Production Status: Smart module
Receipt date of test item: 2021-08-23

2.2 Outline of EUT

The EUT Porta is a Product supporting GSM 850,PCS 1900 and LTE BAND 2/4/5/7.

2.3 Modifications Incorporated in EUT

The EUT has not been modified from what is described by the brand name and unique type identification stated above.

2.4 Equipment Configuration

Equipment configuration list:

Item	Generic Description	Manufacturer	Туре	Serial No.	Remarks
A	Smart module	MeiG Smart Technology Co., Ltd	SLM320-L	M320L16AH B071800060	None

2.5 Other Information

--





3 Summary of Test Results

A brief summary of the tests carried out is shown as following.

Configuration1					
Specification Clause	Name of Test	Result			
15.107	Conducted limits	P			
15.109	Radiated Emission limits	P			

4.Test equipment and Test software

	Test equipment Used:								
Number	Description	otion		Serial Number	Cal. Date	Cal Due	State		
1	Test Receiver	R&S	ESU 26 20Hz-26.5GHz	100350	2021-05-12	2022-06-11	Normal		
2	Trilog Antenna	Schwarzbe ck	VULB9163	01392	2021-02-05	2023-03-04	Normal		
3	Double Ridged Guide Antenna	Schwarzbe ck	HF907	100357	2021-01-11	2023-02-10	Normal		
4	Fully-Anechoic Chamber	ETS			2020-05-26	2022-06-25	Normal		
5	AMN	R/S	ENV216	101128	2021-05-12	2022-06-11	Normal		
6	EMI Test Receiver	R/S	ESCI 9KHz-3GHZ	101214	2021-05-12	2022-06-11	Normal		

Test software Used:							
Number	Test item	Test software name	Manufacturer	Version:			
1	Radiated Emission	EMC32	R/S	V8.51.0			
2	Conducted Emission	EMC32	R/S	V8.51.0			





5 Test Results

5.1 Radiated Emission

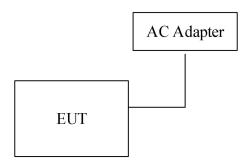
Specifications:	15.109		
Date of Tests	2021-08-26		
Test conditions:	Ambient Temperature:15°C-35°C		
	Relative Humidity:30%-60%		
	Air pressure: 86-106kPa		
Operation Mode	Normal		
Test Results:	Pass		

Limit Level Construction(Except for Class A digital devices):

\ 1	
Frequency Range (MHz)	Quasi-Peak (dBuV/m)
30-88	40
88-216	43.5
216-960	46
Above 960	54

Frequency Range (MHz)	Peak (dBuV/m)	Average (dBuV/m)
Above 1000	74	54

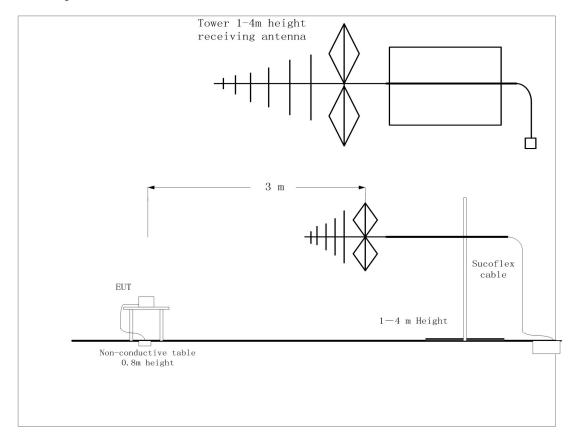
EUT Setup:







Test Setup:



Test Method:

For 30-1000MHz, the EUT was placed on the top of a rotating 0.8m table above the ground at a semi-anechoic chamber. The distance between the EUT and the received antenna was 3 meters. The table was rotated 360 degree and the received antenna mounted on a variable-height antenna tower was varied from 1m to 4m to find the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna were set during the measurement. Tested in accordance with the procedures of ANSI C63.4-2014, section 8.3.

For 1000-18000MHz, the maximal emission value was acquired by adjusting the antenna height, and the table was rotated 360 degree to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna were set during the measurement.

Uncertainty Measurement:

The measurement uncertainty (30MHz-1000MHz) is 5.15 dB (k=2).

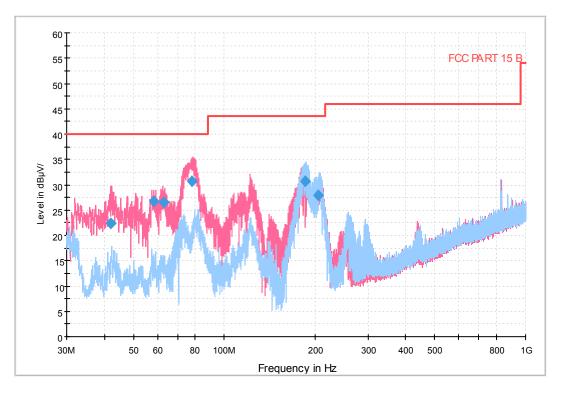
The measurement uncertainty (1000MHz-6000MHz) is 4.68 dB (k=2).

The measurement uncertainty (6000MHz-18000MHz) is 3.91 dB (k=2).



Test Data





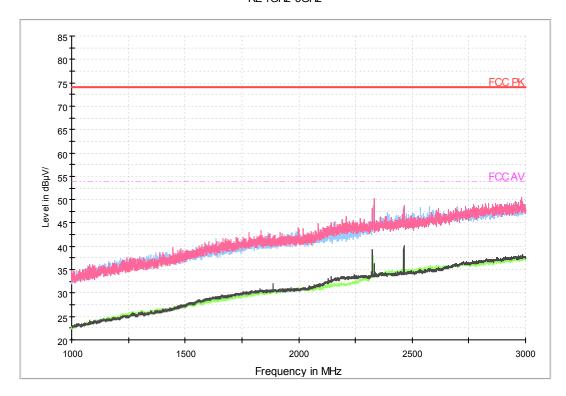
RE 30M-1G

Frequency	QuasiPeak	Limit	Margin	Meas.	Bandwidth	Height	Pol	Azimuth	Corr.
(MHz)	(dBµV/m)	(dBµV/m)	(dB)	Time	(kHz)	(cm)		(deg)	(dB)
42.167500	22.3	40.0	17.7	5000.0	120.000	100.0	V	9.0	-18.4
58.548500	26.7	40.0	13.3	5000.0	120.000	100.0	V	9.0	-19.0
63.043500	26.5	40.0	13.5	5000.0	120.000	100.0	V	-3.0	-20.2
78.291000	30.8	40.0	9.2	5000.0	120.000	100.0	V	190.0	-22.9
186.264000	30.6	43.5	12.9	5000.0	120.000	100.0	Н	270.0	-18.9
204.936500	27.9	43.5	15.6	5000.0	120.000	100.0	Н	269.0	-17.9

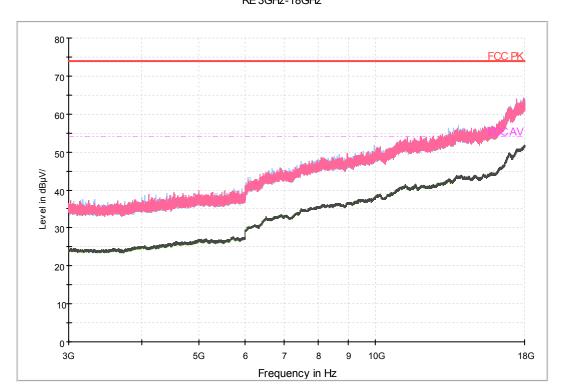
Note: The red curve represents V polarization, the blue curve represents H polarization.



RE 1GHz-3GHz



RE 1-3G RE 3GHz-18GHz



RE 3-18G

Chongqing Academy of Information and Communication Technology

Address: No. 8,Yuma Road, Chayuan New City, Nan'an District, Chongqing, P. R. China,401336

Tel: 0086-23-88069965

FAX:0086-23-88608777





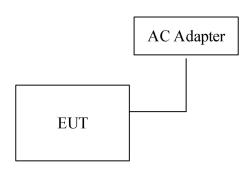
5.2 Conducted Emission

Specifications:	15.107			
Date of Tests	2021-08-30			
Test conditions:	Ambient Temperature:15°C-35°C			
	Relative Humidity:30%-60%			
	Air pressure: 86-106kPa			
Operation Mode	Normal			
Test Results:	Pass			

Limit Level Construction:

Frequency Range (MHz)	Conducted Limit (dBuV)				
	Quasi-peak	Average			
0.15-0.5	66 to 56*	56 to 46*			
0.5-5	56	46			
5-30	60	50			
*Decreases with the logarithm of the	frequency				

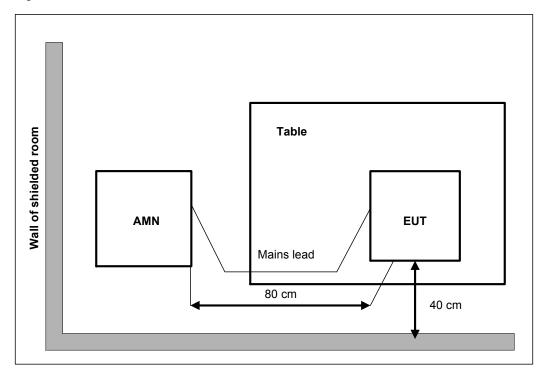
EUT Setup:







Test Setup:



Test Method:

For equipment that is designed to be connected to the public utility (AC) power line, the radio frequency voltage that is conducted back onto the AC power line on any frequency or frequencies with the band 150 kHz to 30MHz shall not exceed the limits. Both lines of the power mains connected to the EUT were checked for maximum conducted interference. Tested in accordance with the procedures of ANSI C63.4-2014, section 7.3

Uncertainty Measurement:

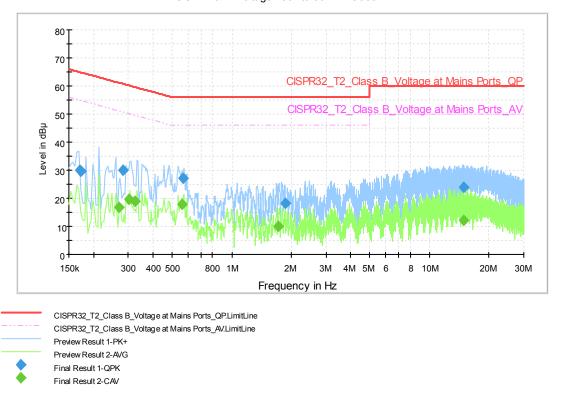
The measurement uncertainty is 1.83 dB (k=2).





Test Data





L&N 150KHz-30MHz

Final Result 1

Frequency	QuasiPeak	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dB µ V)	Time	(kHz)			(dB)	(dB)	(dB µ V)
0.170000	29.9	1000.0	9.000	On	L1	9.7	35.1	65.0
0.172206	29.8	1000.0	9.000	On	L1	9.7	35.1	64.9
0.282831	30.1	1000.0	9.000	On	L1	9.7	30.7	60.7
0.570438	27.3	1000.0	9.000	On	L1	9.7	28.7	56.0
1.870019	18.3	1000.0	9.000	On	L1	9.7	37.7	56.0
14.951512	24.1	1000.0	9.000	On	L1	9.9	35.9	60.0

Final Result 2

Frequency	CAverage	Meas.	Bandwidth	Filter	Line	Corr.	Margin	Limit
(MHz)	(dB µ V)	Time	(kHz)			(dB)	(dB)	(dB µ V)
0.269488	16.8	1000.0	9.000	On	L1	9.7	34.3	51.1
0.303431	19.7	1000.0	9.000	On	L1	9.7	30.5	50.1
0.322831	19.0	1000.0	9.000	On	L1	9.7	30.6	49.6
0.561631	17.7	1000.0	9.000	On	L1	9.7	28.3	46.0
1.716944	9.9	1000.0	9.000	On	L1	9.7	36.1	46.0
14.962706	12.2	1000.0	9.000	On	L1	9.9	37.8	50.0

Chongqing Academy of Information and Communication Technology

Address: No. 8, Yuma Road, Chayuan New City, Nan'an District, Chongqing, P. R. China, 401336
Tel: 0086-23-88069965
FAX:0086-23-88608777





Test photo

See the Pic1~3 in document" I21W00031 JAB".

Annex A External Photos

See the document" I21W00031-External Photos".

Annex B Internal Photos

See the document" I21W00031-Internal Photos".

ANNEX C Deviations from Prescribed Test Methods

No deviation from Prescribed Test Methods.

